

# 1:4 Differential LVDS Fanout Buffer with Selectable Clock Input

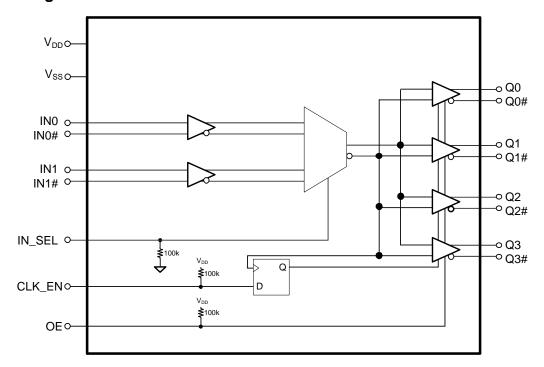
#### **Features**

- Select between low-voltage positive emitter-coupled logic (LVPECL) or low-voltage differential signal (LVDS) input pairs to distribute to four LVDS output pairs
- 30-ps maximum output-to-output skew
- 480-ps maximum propagation delay
- 0.11-ps maximum additive RMS phase jitter at 156.25 MHz (12-kHz to 20-MHz offset)
- Up to 1.5-GHz operation
- Output enable and synchronous clock enable functions
- 20-pin thin shrunk small outline package (TSSOP)
- 2.5-V or 3.3-V operating voltage<sup>[1]</sup>
- Commercial and industrial operating temperature range

#### **Functional Description**

The CY2DL1504 is an ultra-low noise, low-skew, low-propagation delay 1:4 differential LVDS fanout buffer targeted to meet the requirements of high-speed clock distribution applications. The CY2DL1504 can select between LVPECL or LVDS input clock pairs using the IN\_SEL pin. The synchronous clock enable function ensures glitch-free output transitions during enable and disable periods. The output enable function allows the outputs to be asynchronously driven to a high-impedance state. The device has a fully differential internal architecture that is optimized to achieve low-additive jitter and low-skew at operating frequencies of up to 1.5 GHz.

#### Logic Block Diagram



#### Note

Input AC-coupling capacitors are required for voltage-translation applications.





#### Contents

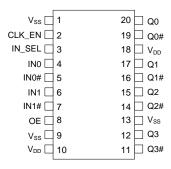
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#### **Pinout**

Figure 1. Pin Diagram – CY2DL1504 20-Pin TSSOP Package



**Table 1. Pin Definitions** 

Pin No.	Pin Name	Pin Type	Description
1,9,13	V <sub>SS</sub>	Power	Ground
2	CLK_EN	Input	Synchronous clock enable. Low-voltage complementary metal oxide semiconductor (LVCMOS)/low-voltage transistor-transistor-logic (LVTTL); When CLK_EN = Low, Q(0:3) outputs are held low and Q(0:3)# outputs are held high
3	IN_SEL	Input	Input clock select pin. LVCMOS/LVTTL; When IN_SEL = Low, the IN0/IN0# differential input pair is active When IN_SEL = High, the IN1/IN1# differential input pair is active
4	IN0	Input	LVDS input clock. Active when IN_SEL = Low
5	IN0#	Input	LVDS complementary input clock. Active when IN_SEL = Low
6	IN1	Input	LVPECL input clock. Active when IN_SEL = High
7	IN1#	Input	LVPECL complementary input clock. Active when IN_SEL = High
8	OE	Input	Output enable. LVCMOS/LVTTL; When OE = Low, Q(0:3) and Q(0:3)# outputs are disabled (see I <sub>OZ</sub> )
10,18	$V_{DD}$	Power	Power supply
11,14,16,19	Q(0:3)#	Output	LVDS complementary output clocks
12,15,17,20	Q(0:3)	Output	LVDS output clocks



# **Absolute Maximum Ratings**

Parameter	Description	Condition	Min	Max	Unit
$V_{DD}$	Supply voltage	Nonfunctional	-0.5	4.6	V
V <sub>IN</sub> <sup>[2]</sup>	Input voltage, relative to V <sub>SS</sub>	Nonfunctional	-0.5	lesser of 4.0 or V <sub>DD</sub> + 0.4	V
V <sub>OUT</sub> <sup>[2]</sup>	DC output or I/O voltage, relative to V <sub>SS</sub>	Nonfunctional	-0.5	lesser of 4.0 or V <sub>DD</sub> + 0.4	V
T <sub>S</sub>	Storage temperature	Nonfunctional	-55	150	°C
ESD <sub>HBM</sub>	Electrostatic discharge (ESD) protection (Human body model)	JEDEC STD 22-A114-B	2000 – \		V
L <sub>U</sub>	Latch up		Meets or exceeds JEDEC Spec JESD78B IC Latchup Test		
UL-94	Flammability rating	At 1/8 in.	V-0		
MSL	Moisture sensitivity level		3		

# **Operating Conditions**

Parameter	Description	Condition	Min	Max	Unit
$V_{DD}$	Supply voltage	2.5-V supply	2.375	2.625	V
		3.3-V supply	3.135	3.465	V
T <sub>A</sub>	Ambient operating temperature	Commercial	0	70	°C
		Industrial	-40	85	°C
t <sub>PU</sub>	Power ramp time	Power-up time for V <sub>DD</sub> to reach minimum specified voltage. (Power ramp must be monotonic)	0.05	500	ms

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Note
2. The voltage on any I/O pin cannot exceed the power pin during power-up. Power supply sequencing is not required.



# **DC Electrical Specifications**

(V<sub>DD</sub> = 3.3 V  $\pm$  5% or 2.5 V  $\pm$  5%; T<sub>A</sub> = 0 °C to 70 °C (Commercial) or –40 °C to 85 °C (Industrial))

Parameter	Description	Condition	Min	Max	Unit
I <sub>DD</sub>	Operating supply current	All LVDS outputs terminated with a load of 100 $\Omega^{[3,\;4]}$	-	61	mA
V <sub>IH1</sub>	Input high voltage, LVDS and LVPECL input clocks, IN0, IN0#, IN1, and IN1#		-	V <sub>DD</sub> + 0.3	V
$V_{IL1}$	Input low voltage, LVDS and LVPECL input clocks, IN0, IN0#, IN1, and IN1#		-0.3	-	V
V <sub>IH2</sub>	Input high voltage, CLK_EN, IN_SEL, and OE	V <sub>DD</sub> = 3.3 V	2.0	V <sub>DD</sub> + 0.3	٧
V <sub>IL2</sub>	Input low voltage, CLK_EN, IN_SEL, and OE	V <sub>DD</sub> = 3.3 V	-0.3	0.8	V
V <sub>IH3</sub>	Input high voltage, CLK_EN, IN_SEL, and OE	V <sub>DD</sub> = 2.5 V	1.7	V <sub>DD</sub> + 0.3	V
$V_{IL3}$	Input low voltage, CLK_EN, IN_SEL, and OE	V <sub>DD</sub> = 2.5 V	-0.3	0.7	V
V <sub>ID_LVDS</sub> <sup>[5]</sup>	LVDS input differential amplitude	See Figure 3 on page 7	0.4	0.8	V
V <sub>ID_LVPECL</sub> <sup>[5]</sup>	LVPECL input differential amplitude	See Figure 3 on page 7	0.4	1.0	V
$V_{ICM}$	Input common mode voltage	See Figure 3 on page 7	0.5	V <sub>DD</sub> – 0.2	V
I <sub>IH</sub>	Input high current, All inputs	Input = $V_{DD}^{[6]}$	_	150	μΑ
I <sub>IL</sub>	Input low current, All inputs	Input = $V_{SS}^{[6]}$	-150	-	μА
V <sub>PP</sub>	LVDS differential output voltage peak to Peak, Single-ended	$V_{DD}$ = 3.3 V or 2.5 V, $R_{TERM}$ = 100 $\Omega$ between Q and Q# pairs [3, 7]	250	470	mV
V <sub>OCM</sub>	LVDS differential output common mode voltage	$V_{DD}$ = 3.3 V or 2.5 V, $R_{TERM}$ = 100 $\Omega$ between Q and Q# pairs [3, 7]	1.125	1.375	٧
$\Delta V_{OCM}$	Change in V <sub>OCM</sub> between complementary output states	$V_{DD}$ = 3.3 V or 2.5 V, $R_{TERM}$ = 100 $\Omega$ between Q and Q# pairs <sup>[3, 7]</sup>	_	50	mV
l <sub>OZ</sub>	Output leakage current	OE = V <sub>SS</sub> , V <sub>OUT</sub> = 0.75V - 1.75V	-15	15	μΑ
R <sub>P</sub>	Internal pull-up/pull-down resistance, LVCMOS logic inputs	CLK_EN has pull-up only IN_SEL has pull-down only OE has pull-up only	60	140	kΩ
C <sub>IN</sub>	Input capacitance	Measured at 10 MHz; per pin	_	3	pF

- Notes

  3. Refer to Figure 2 on page 7.

  4. I<sub>DD</sub> includes current that is dissipated externally in the output termination resistors.

  5. V<sub>ID</sub> minimum of 400 mV is required to meet all output AC Electrical Specifications. The device is functional with V<sub>ID</sub> minimum of greater than 200 mV.

  6. Positive current flows into the input pin, negative current flows out of the input pin.

  7. Refer to Figure 4 on page 7.



# **AC Electrical Specifications**

(V<sub>DD</sub> = 3.3 V  $\pm$  5% or 2.5 V  $\pm$  5%; T<sub>A</sub> = 0 °C to 70 °C (Commercial) or –40 °C to 85 °C (Industrial))

Parameter	Description	Condition	Min	Тур	Max	Unit
F <sub>IN</sub>	Input frequency		DC	_	1.5	GHz
F <sub>OUT</sub>	Output frequency	F <sub>OUT</sub> = F <sub>IN</sub>	DC	_	1.5	GHz
t <sub>PD</sub> <sup>[8]</sup>	Propagation delay input pair to output pair	Input rise/fall time < 1.5 ns (20% to 80%)	-	_	480	ps
t <sub>ODC</sub> <sup>[9]</sup>	Output duty cycle	Diff input at 50% duty cycle Frequency range up to 1 GHz	48	_	52	%
t <sub>SK1</sub> <sup>[10]</sup>	Output-to-output skew	Any output to any output, with same load conditions at DUT	-	_	30	ps
t <sub>SK1 D</sub> <sup>[10]</sup>	Device-to-device output skew	Any output to any output between two or more devices. Devices must have the same input and have the same output load.	-	_	150	ps
PN <sub>ADD</sub>	Additive RMS phase noise	Offset = 1 kHz	_	_	-120	dBc/Hz
	156.25 MHz Input Rise/fall time < 150 ps (20% to 80%) V <sub>ID</sub> > 400 mV	Offset = 10 kHz	_	_	-135	dBc/Hz
		Offset = 100 kHz	_	_	-135	dBc/Hz
		Offset = 1 MHz	_	_	-150	dBc/Hz
		Offset = 10 MHz	_	_	-154	dBc/Hz
		Offset = 20 MHz	_	_	-155	dBc/Hz
t <sub>JIT</sub> <sup>[11]</sup>	Additive RMS phase jitter (Random)	156.25 MHz, 12 kHz to 20 MHz offset; input rise/fall time < 150 ps (20% to 80%), V <sub>ID</sub> > 400 mV	-	_	0.11	ps
t <sub>R</sub> , t <sub>F</sub> <sup>[12]</sup>	Output rise/fall time, single-ended	50% duty cycle at input, 20% to 80% of full swing (V <sub>OL</sub> to V <sub>OH</sub> ) Input rise/fall time < 1.5 ns (20% to 80%) Measured at 1 GHz.	-	_	300	ps
t <sub>SOD</sub>	Time from clock edge to outputs disabled	Synchronous clock enable (CLK_EN) switched low	_	_	700	ps
t <sub>SOE</sub>	Time from clock edge to outputs enabled	Synchronous clock enable (CLK_EN) switched high	_	_	700	ps

#### Notes

<sup>8.</sup> Refer to Figure 5 on page 7.
9. Refer to Figure 6 on page 7.
10. Refer to Figure 7 on page 8.
11. Refer to Figure 8 on page 8.
12. Refer to Figure 9 on page 8.



Figure 2. LVDS Output Termination

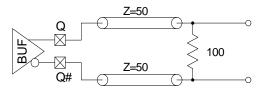


Figure 3. Input Differential and Common Mode Voltages

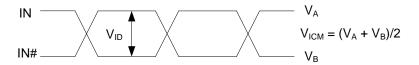


Figure 4. Output Differential and Common Mode Voltages



Figure 5. Input to Any Output Pair Propagation Delay

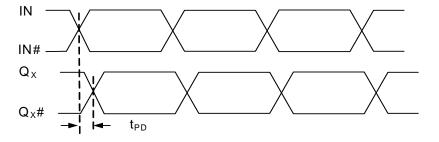


Figure 6. Output Duty Cycle

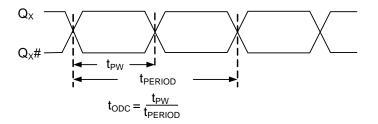




Figure 7. Output-to-output and Device-to-device Skew

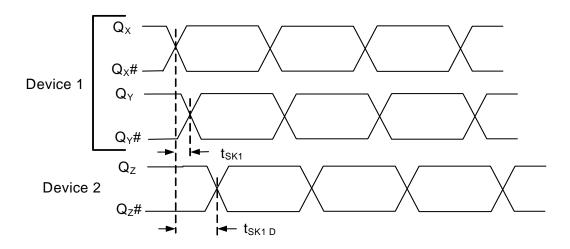


Figure 8. RMS Phase Jitter

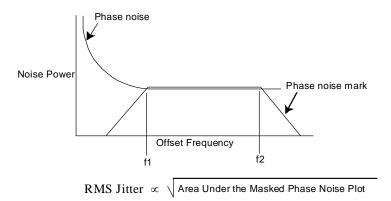


Figure 9. Output Rise/Fall Time

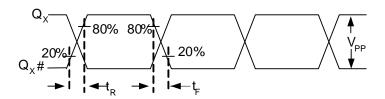
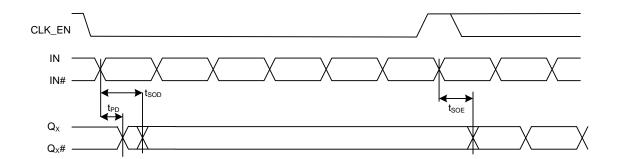




Figure 10. Synchronous Clock Enable Timing

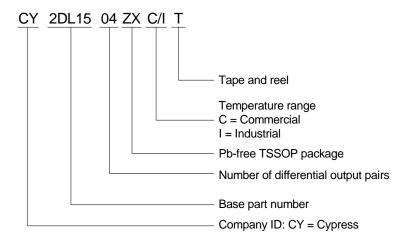




# **Ordering Information**

Part Number	Туре	Production Flow
Pb-free	•	
CY2DL1504ZXC	20-Pin TSSOP	Commercial, 0 °C to 70 °C
CY2DL1504ZXCT	20-Pin TSSOP	Commercial, 0 °C to 70 °C
CY2DL1504ZXI	20-Pin TSSOP	Industrial, –40 °C to 85 °C
CY2DL1504ZXIT	20-Pin TSSOP	Industrial, -40 °C to 85 °C

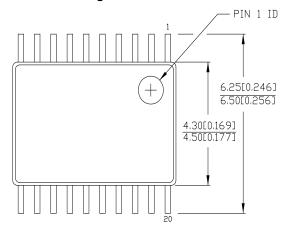
# **Ordering Code Definition**





# **Package Diagram**

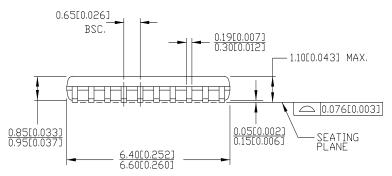
Figure 11. 20-Pin Thin Shrunk Small Outline Package (4.40 mm Body) ZZ20

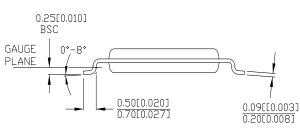


DIMENSIONS IN MM(INCHES) MIN. MAX.

REFERENCE JEDEC MO-153

PART #		
Z20.173	STANDARD PKG.	
ZZ20.173	LEAD FREE PKG.	







# **Acronyms**

Table 2. Acronyms Used in this Document

Acronym	Description	
ESD	Electrostatic discharge	
HBM	Human body model	
JEDEC	Joint electron devices engineering council	
LVDS	Low-voltage differential signal	
LVCMOS	Low-voltage complementary metal oxide semiconductor	
LVPECL	Low-voltage positive emitter-coupled logic	
LVTTL	Low-voltage transistor-transistor logic	
OE	Output enable	
RMS	Root mean square	
TSSOP	Thin shrunk small outline package	

#### **Document Conventions**

**Table 3. Units of Measure** 

Symbol	Unit of Measure		
°C	degree Celsius		
dBc	decibels relative to the carrier		
GHz	giga hertz		
Hz	hertz		
kΩ	kilo ohm		
μA	micro amperes		
μF	micro Farad		
μs	micro second		
mA	milliamperes		
ms	millisecond		
mV	millivolt		
MHz	megahertz		
ns	nano second		
Ω	ohm		
pF	pico Farad		
ps	pico second		
V	volts		
W	watts		



# **Document History Page**

Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	2782891	CXQ	10/09/09	New Datasheet.
*A	2838613	CXQ	01/05/2010	Changed status from "ADVANCE" to "PRELIMINARY". Changed from 0.34 ps to 0.25 ps maximum additive jitter in "Features" on page 1 and in $t_{JIT}$ in the AC Electrical Specs table on page 5. Added $t_{PU}$ spec to the Operating Conditions table on page 3. Changed max $I_{DD}$ spec in the DC Electrical Specs table on page 4 from 60 mA to 61 mA. Removed $V_{OD}$ and $\Delta V_{OD}$ specs from the DC Electrical Specs table on page 4. Changed $I_{OZ}$ in the DC Electrical Specs table on page 4 from min of -10 uA to -15 uA and from max of 10 uA to 15 uA. Added $R_P$ spec in the DC Electrical Specs table on page 4. Min = 60 k $\Omega$ , Max = 140 k $\Omega$ . Added a measurement definition for $C_{IN}$ in the DC Electrical Specs table on page 4. Added $V_{PP}$ and $\Delta V_{PP}$ specs to the AC Electrical Specs table on page 5. $V_{PP}$ min = 250 mV and max = 470 mV; $\Delta V_{PP}$ max = 50 mV. Changed letter case and some names of all the timing parameters in the AC Electrical Specs table on page 5. Lowered all additive phase noise mask specs by 3 dB in the AC Electrical Specs table on page 5 that input rise/fall time must be less than 1.5 ns (20% to 80%). Changed letter case and some names of all the timing parameters in Figures 4, 5, 6, 7 and 9, to be consistent with EROS. Updated Figure 4 with definition for $V_{PP}$ and $\Delta V_{PP}$
	3010332	CXQ	08/18/2010	Changed from 0.25 ps to 0.11 ps maximum additive jitter in "Features" on page 1 and in $t_{JIT}$ in the AC Electrical Specs table on page 5. Added "Functional equivalent to ICS8543i" to the "Features" section. Changed pin 13 in Figure 1 and Table 1 from $V_{DD}$ to $V_{SS}$ . Changed pin 8 description in Table 1 from "high impedance" to "disabled". Added note 6 to describe $I_{IH}$ and $I_{IL}$ specs. Removed reference to data distribution from "Functional Description". Changed $R_P$ for diff inputs from 100 $k\Omega$ to 150 $k\Omega$ in the Logic Block Diagram and from 60 $k\Omega$ min / 140 $k\Omega$ max to 90 $k\Omega$ min / 210 $k\Omega$ max in the DC Electrical Specs table. Split $V_{ID}$ into separate specs in DC Electrical Specs table: 0.4 V min and 0.8 V max for LVDS, 0.4 V min and 1.0 V max for LVPECL. Updated phase noise specs for 1 k/10 k/100 k/1 M/10 M/20 MHz offset to -120/-130/-135/-150/-150/-150dBc/Hz, respectively, in the AC Electrical Specs table. Added "Frequency range up to 1 GHz" condition to $t_{ODC}$ spec. Changed $t_{OD}$ in the AC Electrical Specs table from 3 ns max to 5 ns max. Added Acronyms and Ordering Code Definition.



Revision	ECN	Orig. of Change	Submission Date	Description of Change
, ,	3090644	CXQ	11/19/2010	Changed V <sub>IN</sub> and V <sub>OUT</sub> specs from 4.0V to "lesser of 4.0 or V <sub>DD</sub> + 0.4" Removed 200mA min LU spec, replaced with "Meets or exceeds JEDEC Spec JESD78B IC Latchup Test" Added "V <sub>OUT</sub> = 0.75V - 1.75V" to I <sub>OZ</sub> comments. Moved V <sub>PP</sub> from AC spec table to DC spec table, removed $\Delta V_{PP}$ Removed R <sub>P</sub> spec for differential input clock pins IN <sub>X</sub> and IN <sub>X</sub> #. Changed C <sub>IN</sub> condition to "Measured at 10 MHz". Changed PN <sub>ADD</sub> specs for 10kHz, 10MHz, and 20MHz offsets. Added "Measured at 1 GHz" to t <sub>R</sub> , t <sub>F</sub> spec condition. Removed specs t <sub>S</sub> , t <sub>H</sub> , t <sub>OD</sub> , and t <sub>OE</sub> from AC spec table. Removed $\Delta V_{PP}$ reference from Figure 4.
*D	3135189	CXQ	01/12/2011	Removed "Preliminary" status heading. Removed "Functional equivalent" bullet on page 1. Added "(see $I_{OZ}$ )" note to pin 8 description in Pin Definitions. Fixed typo and removed resistors from $IN_X/IN_X\#$ in Logic Block Diagram Added Figure 10 to describe $T_{SOE}$ and $T_{SOD}$ .
*E	3090938	CXQ	02/25/11	Post to external web.



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